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				U.S. PATENT DOCUMENTS			
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		DOCUMENT NUMBER	DATE	COUNTRY	,		TRANSLATION S NO
	AO	2000-172060	06/23/00	JP (with English abstract)			NO
	AP	2002-87591	03/27/02	JP (with English abstract)			NO
	AO	2002-341648	11/29/02	JP (with English abstract)			NO
	AR	2002-307737	10/23/02	JP (with English abstract)			NO
	AS	2004-18138	01/22/04	JP (with English abstract)			NO
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